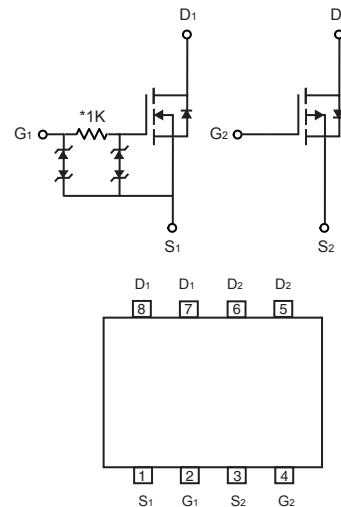
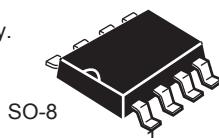


## Dual Enhancement Mode Field Effect Transistor (N and P Channel)

## FEATURES

- 20V, 7.5A,  $R_{DS(ON)} = 22m\Omega$  @ $V_{GS} = 10V$ .  
 $R_{DS(ON)} = 24m\Omega$  @ $V_{GS} = 4.5V$ .  
 $R_{DS(ON)} = 33m\Omega$  @ $V_{GS} = 2.5V$ .
- -20V, -4.0A,  $R_{DS(ON)} = 80m\Omega$  @ $V_{GS} = -10V$ .  
 $R_{DS(ON)} = 100m\Omega$  @ $V_{GS} = -4.5V$ .  
 $R_{DS(ON)} = 150m\Omega$  @ $V_{GS} = -2.5V$ .
- Super high dense cell design for extremely low  $R_{DS(ON)}$ .
- High power and current handing capability.
- Lead free product is acquired.
- Surface mount Package.

ABSOLUTE MAXIMUM RATINGS  $T_A = 25^\circ C$  unless otherwise noted

Parameter	Symbol	N-Channel	P-Channel	Units
Drain-Source Voltage	$V_{DS}$	20	-20	V
Gate-Source Voltage	$V_{GS}$	$\pm 12$	$\pm 12$	V
Drain Current-Continuous	$I_D$	7.5	-4.0	A
Drain Current-Pulsed <sup>a</sup>	$I_{DM}$	25	-15	A
Maximum Power Dissipation	$P_D$	2.0		W
Operating and Store Temperature Range	$T_J, T_{stg}$	-55 to 150		°C

## Thermal Characteristics

Parameter	Symbol	Limit	Units
Thermal Resistance, Junction-to-Ambient <sup>b</sup>	$R_{\theta JA}$	62.5	°C/W



CEM2539

**N-Channel Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	20			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 20\text{V}, V_{\text{GS}} = 0\text{V}$			1	$\mu\text{A}$
Gate Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 12\text{V}, V_{\text{DS}} = 0\text{V}$			$\pm 10$	$\mu\text{A}$
Gate Body Leakage Current	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 12\text{V}, V_{\text{DS}} = 0\text{V}$			$\pm 10$	$\mu\text{A}$
<b>On Characteristics<sup>c</sup></b>						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}} = V_{\text{DS}}, I_D = 250\mu\text{A}$	0.5		1.2	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 6\text{A}$		17	22	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5\text{V}, I_D = 6\text{A}$		20	24	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5\text{V}, I_D = 5\text{A}$		25	33	$\text{m}\Omega$
<b>Dynamic Characteristics<sup>d</sup></b>						
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}} = 15\text{V}, I_D = 6\text{A}$		15		S
<b>Switching Characteristics<sup>d</sup></b>						
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 10\text{V}, I_D = 1\text{A}, \square$ $V_{\text{GS}} = 4.5\text{V}, R_{\text{GEN}} = 6\Omega$		0.35	0.7	$\mu\text{s}$
Turn-On Rise Time	$t_r$			0.87	1.8	$\mu\text{s}$
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$			3.60	7.5	$\mu\text{s}$
Turn-Off Fall Time	$t_f$			2.01	4.3	$\mu\text{s}$
Total Gate Charge	$Q_g$	$V_{\text{DS}} = 10\text{V}, I_D = 5\text{A},$ $V_{\text{GS}} = 4.5\text{V}$		4.3	5.7	nC
Gate-Source Charge	$Q_{gs}$			1.1		nC
Gate-Drain Charge	$Q_{gd}$			2.5		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Drain-Source Diode Forward Current <sup>b</sup>	$I_S$				1.5	A
Drain-Source Diode Forward Voltage <sup>c</sup>	$V_{\text{SD}}$	$V_{\text{GS}} = 0\text{V}, I_S = 1.5\text{A}$			1.2	V

## Notes :

- a.Repetitive Rating : Pulse width limited by maximum junction temperature. $\square$
- b.Surface Mounted on FR4 Board,  $t \leq 10 \text{ sec.}$  $\square$
- c.Pulse Test : Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 2\%$ . $\square$
- d.Guaranteed by design, not subject to production testing. $\square$



CEM2539

**P-Channel Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

Parameter	Symbol	Test Condition	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	$\text{BV}_{\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = -250\mu\text{A}$	-20			V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = -20\text{V}, V_{\text{GS}} = 0\text{V}$			-1	$\mu\text{A}$
Gate Body Leakage Current, Forward	$I_{\text{GSSF}}$	$V_{\text{GS}} = 12\text{V}, V_{\text{DS}} = 0\text{V}$			100	nA
Gate Body Leakage Current, Reverse	$I_{\text{GSSR}}$	$V_{\text{GS}} = -12\text{V}, V_{\text{DS}} = 0\text{V}$			-100	nA
<b>On Characteristics<sup>c</sup></b>						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{GS}} = V_{\text{DS}}, I_D = -250\mu\text{A}$	-0.5		-1	V
Static Drain-Source On-Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = -10\text{V}, I_D = -3.5\text{A}$		70	80	$\text{m}\Omega$
		$V_{\text{GS}} = -4.5\text{V}, I_D = -2.8\text{A}$		80	100	$\text{m}\Omega$
		$V_{\text{GS}} = -2.5\text{V}, I_D = -2.0\text{A}$		90	150	$\text{m}\Omega$
<b>Dynamic Characteristics<sup>d</sup></b>						
Forward Transconductance	$g_{\text{FS}}$	$V_{\text{DS}} = -5\text{V}, I_D = -3.5\text{A}$		10		S
Input Capacitance	$C_{\text{iss}}$	$V_{\text{DS}} = -10\text{V}, V_{\text{GS}} = 0\text{V}, f = 1.0 \text{ MHz}$		1175		pF
Output Capacitance	$C_{\text{oss}}$			230		pF
Reverse Transfer Capacitance	$C_{\text{rss}}$			130		pF
<b>Switching Characteristics<sup>d</sup></b>						
Turn-On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = -10\text{V}, I_D = -4\text{A}, V_{\text{GS}} = -4.5\text{V}, R_{\text{GEN}} = 3\Omega$		14.4	28.8	ns
Turn-On Rise Time	$t_r$			9	18	ns
Turn-Off Delay Time	$t_{\text{d}(\text{off})}$			72.8	145.6	ns
Turn-Off Fall Time	$t_f$			35	70	ns
Total Gate Charge	$Q_g$	$V_{\text{DS}} = -10\text{V}, I_D = -4\text{A}, V_{\text{GS}} = -4.5\text{V}$		10.6	14.1	nC
Gate-Source Charge	$Q_{\text{gs}}$			1.5		nC
Gate-Drain Charge	$Q_{\text{gd}}$			2.5		nC
<b>Drain-Source Diode Characteristics and Maximum Ratings</b>						
Drain-Source Diode Forward Current <sup>b</sup>	$I_s$				-4.0	A
Drain-Source Diode Forward Voltage <sup>c</sup>	$V_{\text{SD}}$	$V_{\text{GS}} = 0\text{V}, I_s = -1.0\text{A}$			-1.0	V

## Notes :

- a.Repetitive Rating : Pulse width limited by maximum junction temperature.
- b.Surface Mounted on FR4 Board, t ≤ 10 sec..
- c.Pulse Test : Pulse Width ≤ 300μs, Duty Cycle ≤ 2%.
- d.Guaranteed by design, not subject to production testing.



## N-CHANNEL

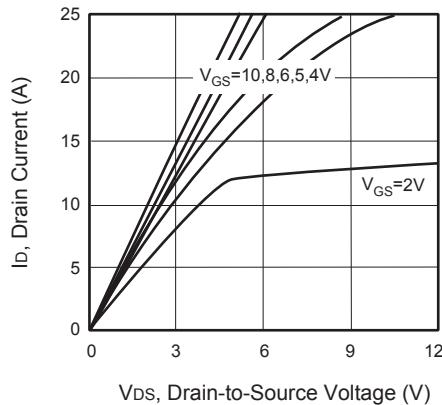


Figure 1. Output Characteristics

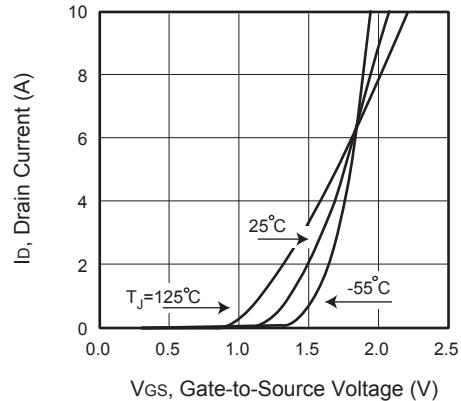


Figure 2. Transfer Characteristics

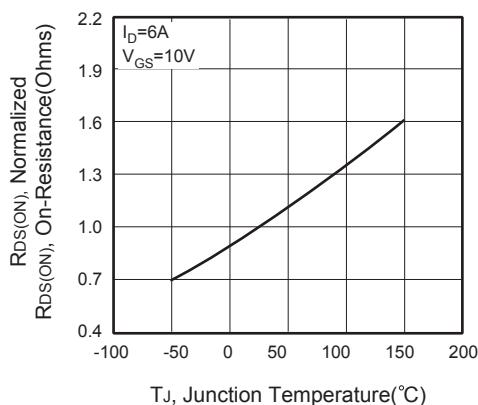


Figure 3. On-Resistance Variation with Temperature

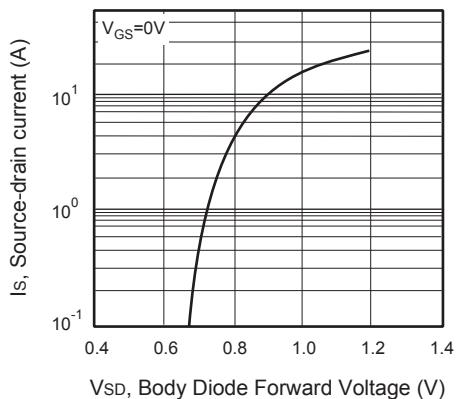


Figure 4. Body Diode Forward Voltage Variation with Source Current

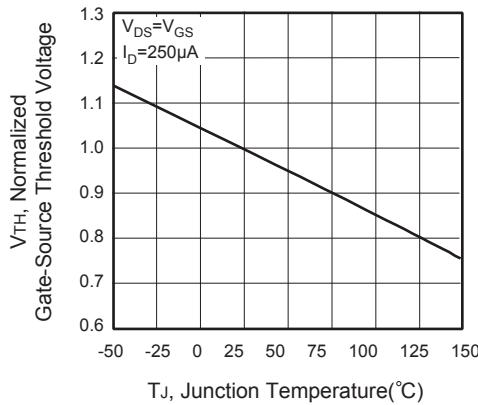
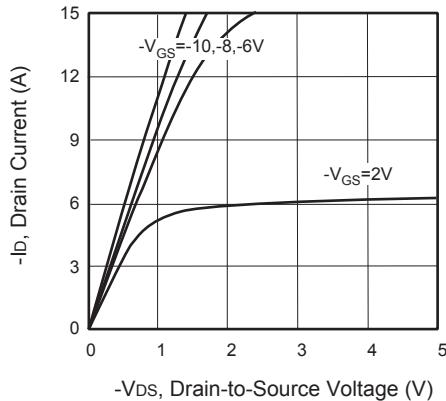
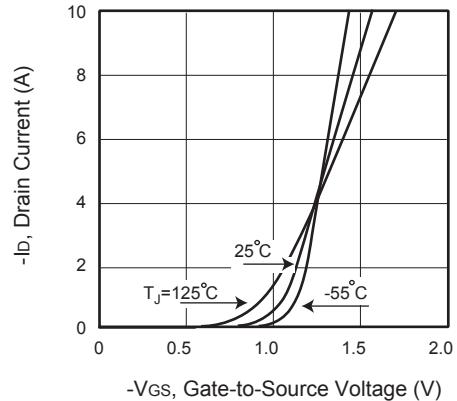
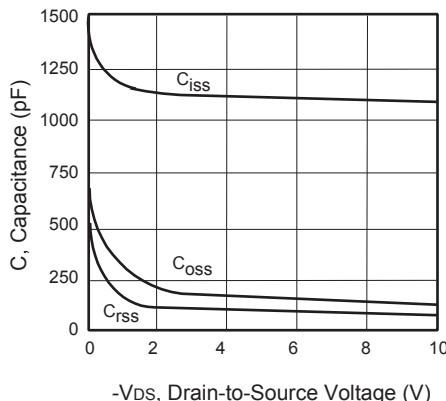
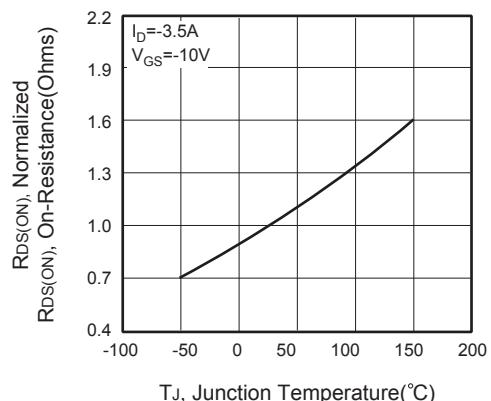
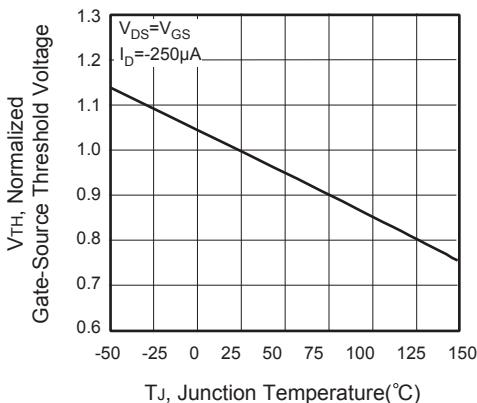
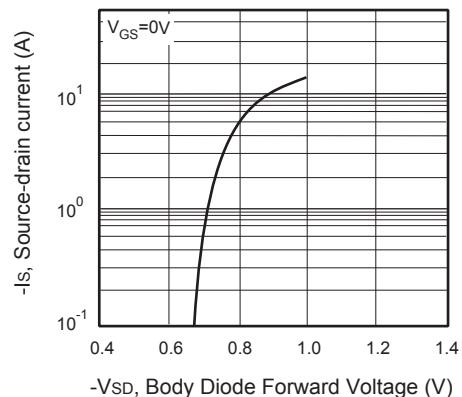
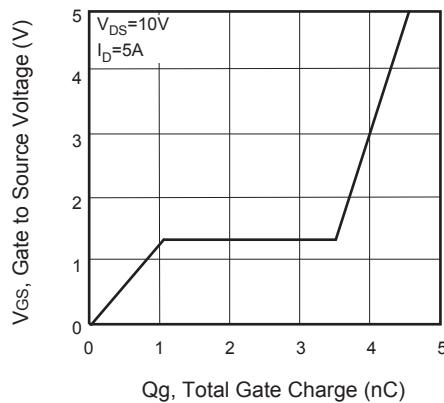
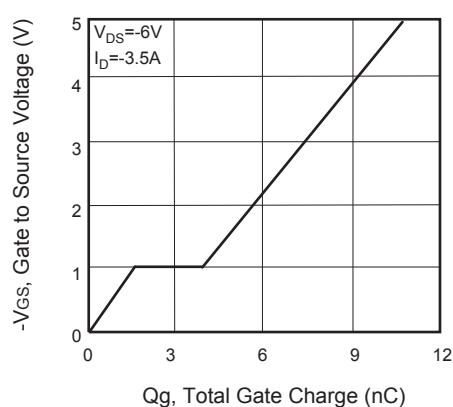
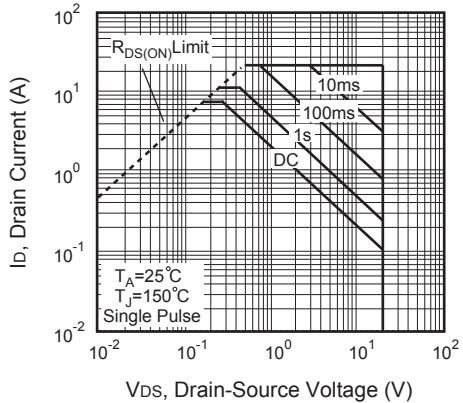
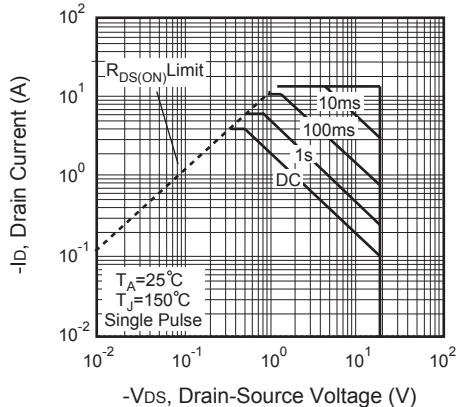


Figure 5. Gate Threshold Variation with Temperature

**P-CHANNEL**

**Figure 7. Output Characteristics**

**Figure 8. Transfer Characteristics**

**Figure 9. Capacitance**

**Figure 10. On-Resistance Variation with Temperature**

**Figure 11. Gate Threshold Variation with Temperature**

**Figure 12. Body Diode Forward Voltage Variation with Source Current**

**N-CHANNEL**

**Figure 13. Gate Charge**
**P-CHANNEL**

**Figure 15. Gate Charge**

**Figure 14. Maximum Safe Operating Area**

**Figure 16. Maximum Safe Operating Area**

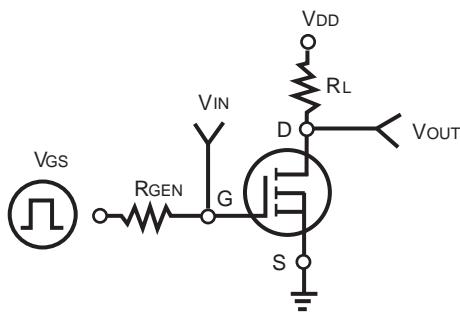


Figure 17. Switching Test Circuit

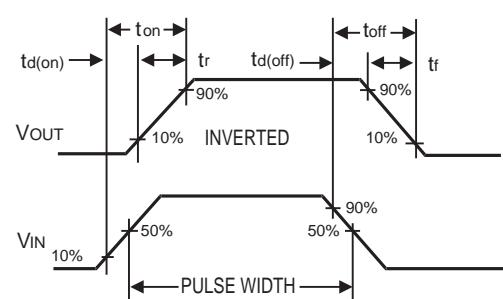


Figure 18. Switching Waveforms

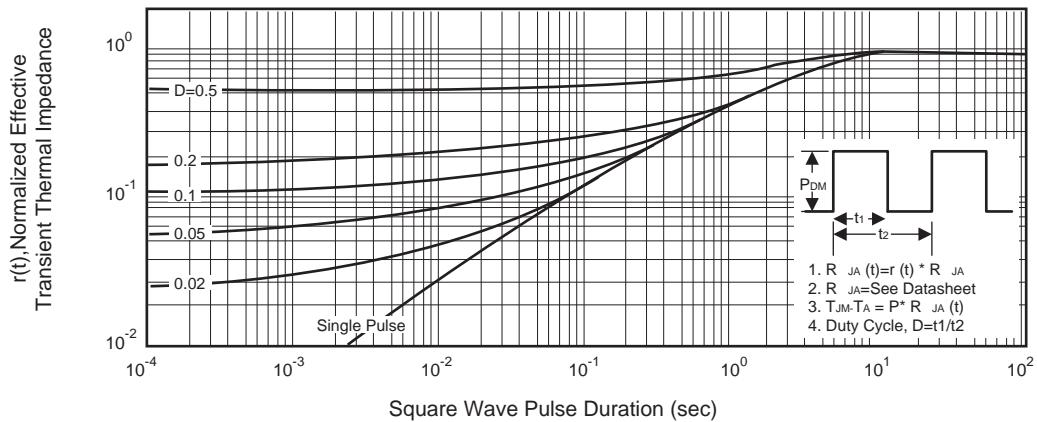


Figure 19. Normalized Thermal Transient Impedance Curve